_	 	 lote	

Application/Control No.	Ap Re
	1,00

Applicant(s)/Patent	under
Reexamination	

10/771,615

Examiner

WILSON ET AL.
Art Unit

William Oen

2855

	SEAR	CHED	
Class	Subclass	Date	Examiner
73	146 146.4 146.5	7/7/2005	wo
152	152.1	[. 1
340	442-447	J	V
		•	

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
Same as	Above	7/7/2005	wo	
_				
	_			
	•			

DATE 7/7/2005	EXMR WO
7/7/2005	wo